

## N - CHANNEL ENHANCEMENT MODE POWER MOS TRANSISTOR

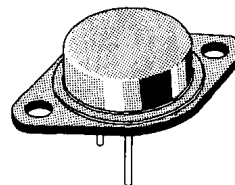
| TYPE    | V <sub>DSS</sub> | R <sub>DS(on)</sub> | I <sub>D</sub> |
|---------|------------------|---------------------|----------------|
| SGSP577 | 200 V            | 0.17 $\Omega$       | 20 A           |

- HIGH SPEED SWITCHING APPLICATIONS
- HIGH CURRENT - FOR TELECOMM POWER SUPPLIES
- ULTRA FAST SWITCHING
- EASY DRIVE FOR REDUCED COST AND SIZE

### INDUSTRIAL APPLICATIONS:

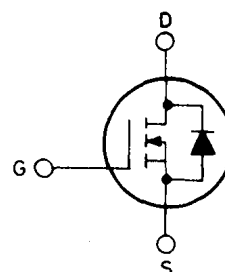
- SWITCHING MODE POWER SUPPLIES
- MOTOR CONTROLS FOR ROBOTICS.

N - channel enhancement mode POWER MOS field effect transistor. Easy drive and very fast switching times make this POWER MOS transistor ideal for high speed switching applications. Typical applications include robotics, UPS, SMPS and DC/DC converters, electric vehicle drives and a DC switch for telecommunications.



**TO-3**

### INTERNAL SCHEMATIC DIAGRAM



### ABSOLUTE MAXIMUM RATINGS

|                      |                                                       |             |      |
|----------------------|-------------------------------------------------------|-------------|------|
| V <sub>DS</sub>      | Drain-source voltage (V <sub>GS</sub> = 0)            | 200         | V    |
| V <sub>DGR</sub>     | Drain-gate voltage (R <sub>GS</sub> = 20 K $\Omega$ ) | 200         | V    |
| V <sub>GS</sub>      | Gate-source voltage                                   | $\pm 20$    | V    |
| I <sub>D</sub>       | Drain current (cont.) at T <sub>c</sub> = 25°C        | 20          | A    |
| I <sub>D</sub>       | Drain current (cont.) at T <sub>c</sub> = 100°C       | 13          | A    |
| I <sub>DM</sub> (*)  | Drain current (pulsed)                                | 80          | A    |
| I <sub>DLM</sub> (*) | Drain inductive current, clamped                      | 80          | A    |
| P <sub>tot</sub>     | Total dissipation at T <sub>c</sub> < 25°C            | 150         | W    |
|                      | Derating factor                                       | 1.2         | W/°C |
| T <sub>stg</sub>     | Storage temperature                                   | - 65 to 150 | °C   |
| T <sub>j</sub>       | Max. operating junction temperature                   | 150         | °C   |

(\*) Pulse width limited by safe operating area

## THERMAL DATA

|                  |                                                |     |      |      |
|------------------|------------------------------------------------|-----|------|------|
| $R_{thj - case}$ | Thermal resistance junction-case               | max | 0.83 | °C/W |
| $T_L$            | Maximum lead temperature for soldering purpose |     | 275  | °C   |

ELECTRICAL CHARACTERISTICS ( $T_{case} = 25^\circ\text{C}$  unless otherwise specified)

| Parameters | Test Conditions | Min. | Typ. | Max. | Unit |
|------------|-----------------|------|------|------|------|
|------------|-----------------|------|------|------|------|

## OFF

|                |                                                  |                                                                                                      |     |  |             |                                |
|----------------|--------------------------------------------------|------------------------------------------------------------------------------------------------------|-----|--|-------------|--------------------------------|
| $V_{(BR) DSS}$ | Drain-source breakdown voltage                   | $I_D = 250 \mu\text{A}$<br>$V_{GS} = 0$                                                              | 200 |  |             | V                              |
| $I_{DSS}$      | Zero gate voltage drain current ( $V_{GS} = 0$ ) | $V_{DS} = \text{Max Rating}$<br>$V_{DS} = \text{Max Rating} \times 0.8$<br>$T_c = 125^\circ\text{C}$ |     |  | 250<br>1000 | $\mu\text{A}$<br>$\mu\text{A}$ |
| $I_{GSS}$      | Gate-body leakage current ( $V_{DS} = 0$ )       | $V_{GS} = \pm 20 \text{ V}$                                                                          |     |  | $\pm 100$   | nA                             |

## ON (\*)

|               |                                   |                                                                                                                        |   |  |              |                      |
|---------------|-----------------------------------|------------------------------------------------------------------------------------------------------------------------|---|--|--------------|----------------------|
| $V_{GS (th)}$ | Gate threshold voltage            | $V_{DS} = V_{GS}$<br>$I_D = 250 \mu\text{A}$                                                                           | 2 |  | 4            | V                    |
| $R_{DS (on)}$ | Static drain-source on resistance | $V_{GS} = 10 \text{ V}$ $I_D = 10 \text{ A}$<br>$V_{GS} = 10 \text{ V}$ $I_D = 10 \text{ A}$ $T_c = 100^\circ\text{C}$ |   |  | 0.17<br>0.34 | $\Omega$<br>$\Omega$ |

## DYNAMIC

|                                     |                                                                         |                                                                |   |      |                    |                |
|-------------------------------------|-------------------------------------------------------------------------|----------------------------------------------------------------|---|------|--------------------|----------------|
| $g_{fs}$                            | Forward transconductance                                                | $V_{DS} = 25 \text{ V}$<br>$I_D = 10 \text{ A}$                | 8 |      |                    | mho            |
| $C_{iss}$<br>$C_{oss}$<br>$C_{rss}$ | Input capacitance<br>Output capacitance<br>Reverse transfer capacitance | $V_{DS} = 25 \text{ V}$<br>$V_{GS} = 0$<br>$f = 1 \text{ MHz}$ |   | 1900 | 2200<br>550<br>260 | pF<br>pF<br>pF |

## SWITCHING

|             |                     |                                                                                                                      |  |     |     |    |
|-------------|---------------------|----------------------------------------------------------------------------------------------------------------------|--|-----|-----|----|
| $t_d (on)$  | Turn-on time        | $V_{DD} = 100 \text{ V}$<br>$V_i = 10 \text{ V}$<br>$I_D = 10 \text{ A}$<br>$R_i = 4.7 \Omega$<br>(see test circuit) |  | 30  | 40  | ns |
| $t_r$       | Rise time           |                                                                                                                      |  | 50  | 65  | ns |
| $t_d (off)$ | Turn-off delay time |                                                                                                                      |  | 110 | 145 | ns |
| $t_f$       | Fall time           |                                                                                                                      |  | 35  | 45  | ns |

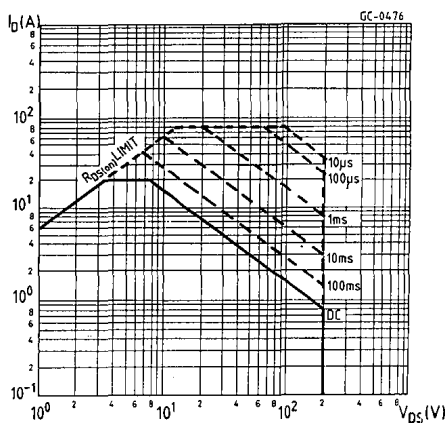
## ELECTRICAL CHARACTERISTICS (Continued)

| Parameters                                    | Test Conditions                                                           | Min. | Typ. | Max. | Unit |
|-----------------------------------------------|---------------------------------------------------------------------------|------|------|------|------|
| $I_{SD}$ Source-drain current                 |                                                                           |      |      | 20   | A    |
| $I_{SDM}^{(*)}$ Source-drain current (pulsed) |                                                                           |      |      | 80   | A    |
| $V_{SD}$ Forward on voltage                   | $I_{SD} = 20\text{ A}$ $V_{GS} = 0$                                       |      |      | 1.3  | V    |
| $t_{rr}$ Reverse recovery time                | $I_{SD} = 20\text{ A}$ $V_{GS} = 0$<br>$di/dt = 100\text{ A}/\mu\text{s}$ |      | 320  |      | ns   |

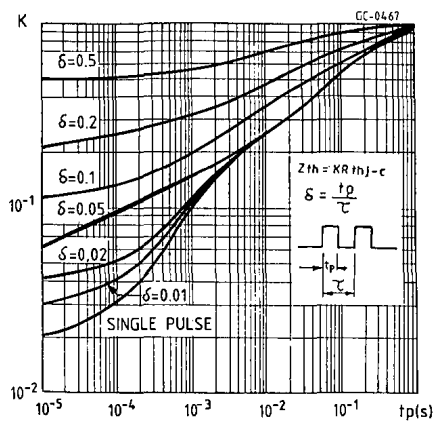
(\*) Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

(\*) Pulse width limited by safe operating area

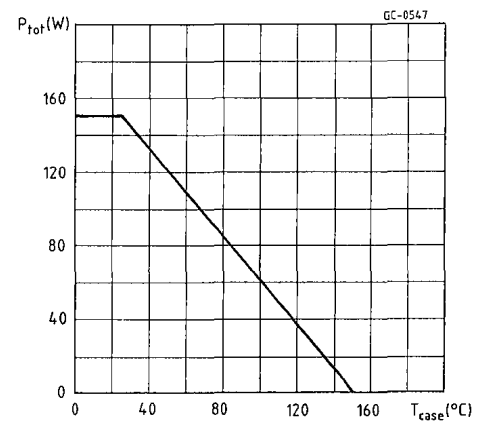
Safe operating areas



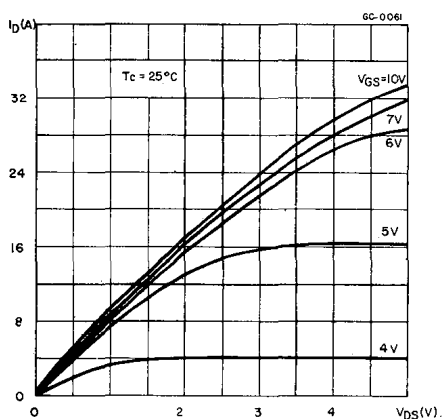
Thermal impedance



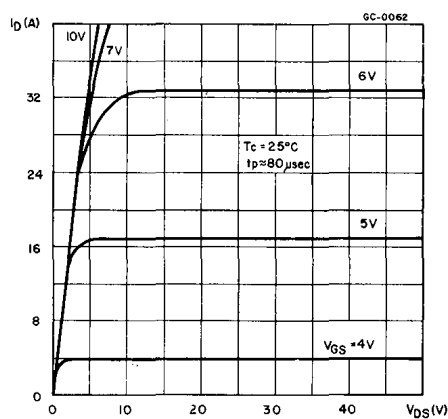
Derating curve



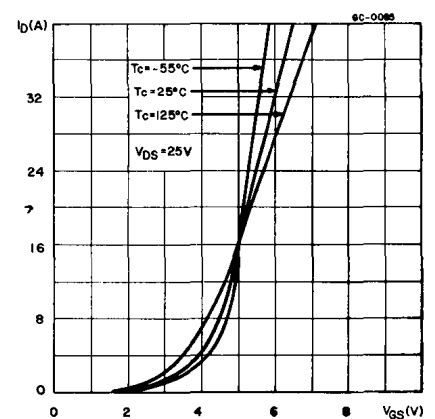
Output characteristics



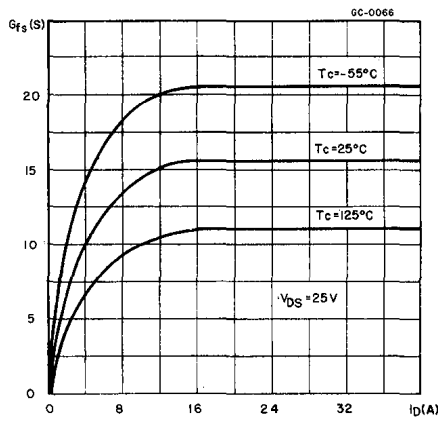
Output characteristics



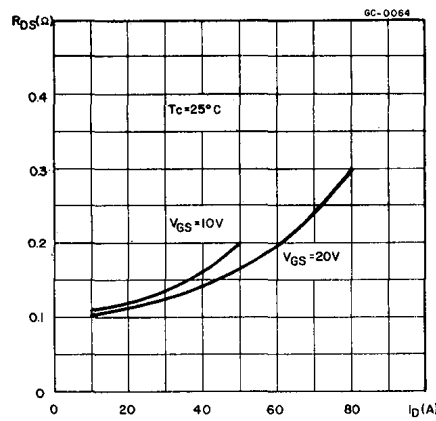
Transfer characteristics



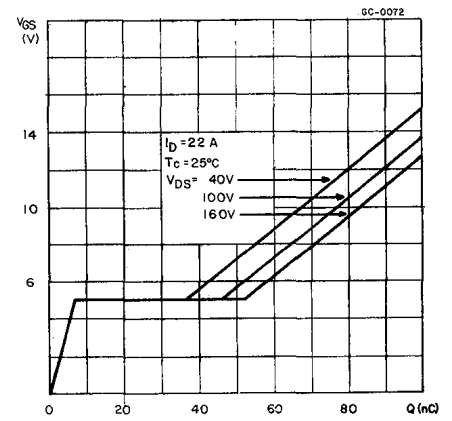
Transconductance



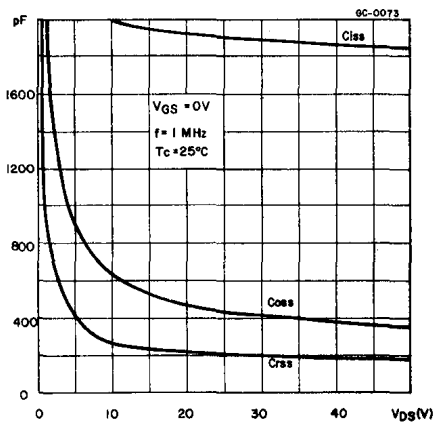
Static drain-source on resistance



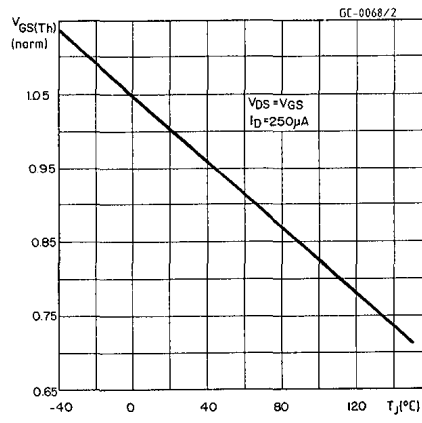
Gate charge vs gate-source voltage



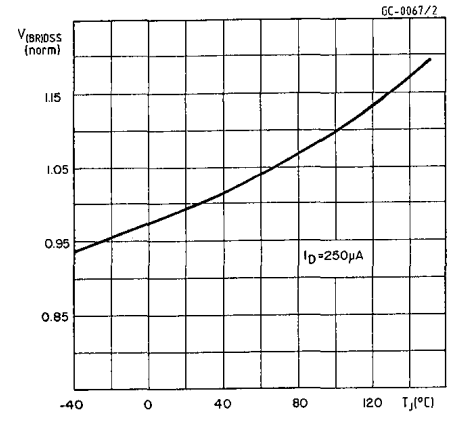
Capacitance variation



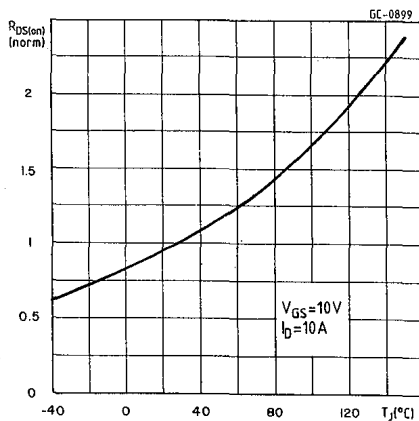
Normalized gate threshold voltage vs temperature



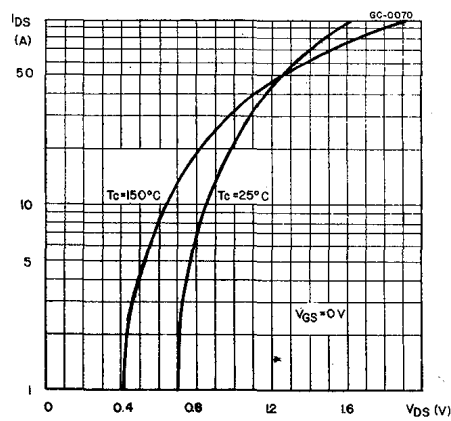
Normalized breakdown voltage vs temperature



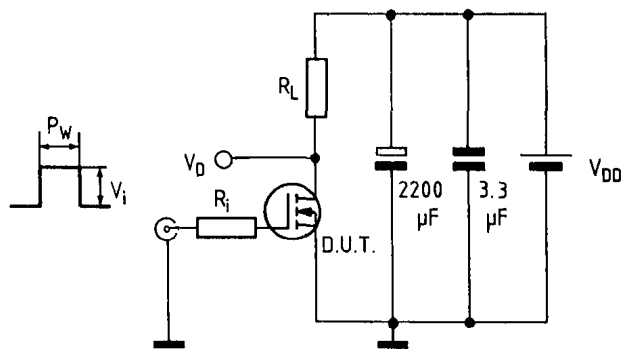
Normalized on resistance vs temperature



Source-drain diode forward characteristics

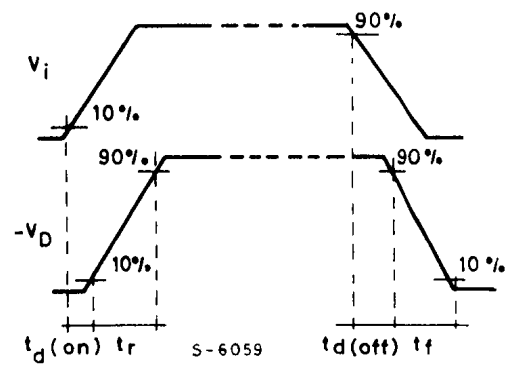


## Switching times test circuit for resistive load

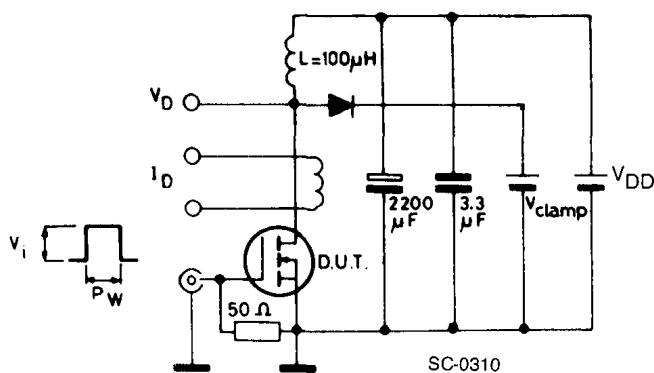
Pulse width  $\leq 100 \mu\text{s}$ Duty cycle  $\leq 2\%$  $V_i = 10 \text{ V}$ 

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## Switching time waveforms for resistive load

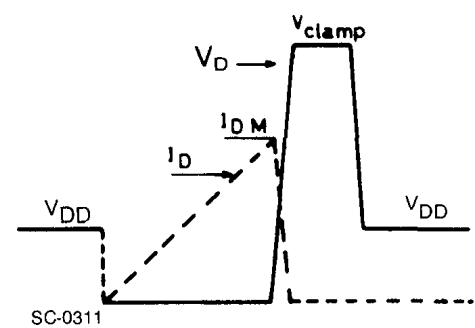


## Clamped inductive load test circuit

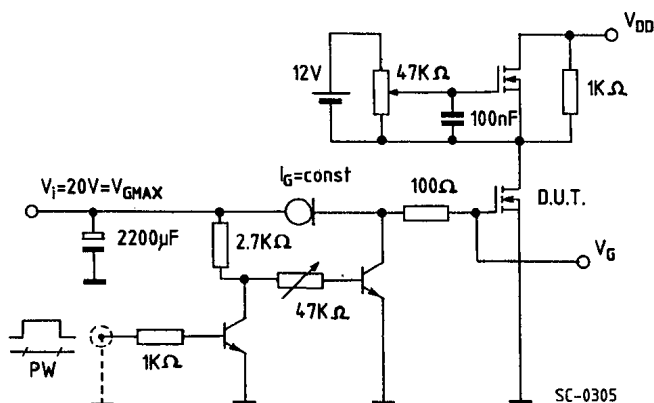


$V_i = 12 \text{ V}$  - Pulse width: adjusted to obtain specified  $I_{DM}$ ,  $V_{\text{clamp}} = 0.75 V_{(BR) DSS}$ .

## Clamped inductive waveforms



## Gate charge test circuit

PW adjusted to obtain required  $V_G$ Body-drain diode  $t_{rr}$  measurement  
Jedec test circuit